

January 2014

FDMC86340

N-Channel Shielded Gate Power Trench $^{\circledR}$ MOSFET 80 V, 48 A, 6.5 m Ω

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)}$ = 6.5 m Ω at V_{GS} = 10 V, I_D = 14 A
- Max $r_{DS(on)}$ = 8.5 m Ω at V_{GS} = 8 V, I_D = 12 A
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free
- RoHS Compliant

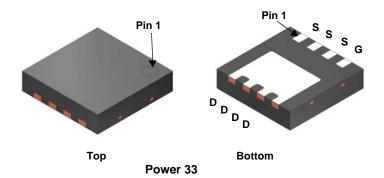


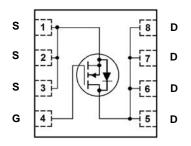
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Application

■ DC-DC Conversion





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol		Paramet		Ratings	Units	
V _{DS}	Drain to Source Voltage				80	V
V _{GS}	Gate to Source V	oltage			±20	V
	Drain Current	-Continuous	T _C = 25 °C		48	
I _D		-Continuous	T _A = 25 °C	(Note 1a)	14	Α
	-Pulsed (Note 4)				200	
E _{AS}	Single Pulse Ava	lanche Energy		(Note 3)	216	mJ
D	Power Dissipation	n	T _C = 25 °C		54	W
P_D	Power Dissipation	า	T _A = 25 °C	(Note 1a)	2.3	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range				-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	2.3	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86340	FDMC86340	Power33	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units			
Off Chara	Off Characteristics								
BV_DSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	80			V			
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		46		mV/°C			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μΑ			
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA			

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$	2.0	3.4	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-10		mV/°C
		V _{GS} = 10 V, I _D = 14 A		5.0	6.5	
r _{DS(on)} Static Drain to Source On Resistance	V _{GS} = 8 V, I _D = 12 A		6.0	8.5	mΩ	
, ,		V _{GS} = 10 V, I _D = 14 A, T _J = 125 °C		8.5	11	
g _{FS}	Forward Transconductance	V _{DD} = 10 V, I _D = 14 A		36		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40.V.V 0.V		2775	3885	pF
C _{oss}	Output Capacitance	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		468	655	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12		15	25	pF
R_q	Gate Resistance		0.1	0.7	2.1	Ω

Switching Characteristics

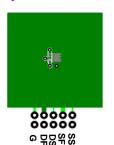
t _{d(on)}	Turn-On Delay Time		20	32	ns
t _r	Rise Time	V _{DD} = 40 V, I _D = 14 A,	7.9	16	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	23	37	ns
t _f	Fall Time		5.1	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V	38	53	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 8 \text{ V}$ $V_{DD} = 40 \text{ V},$	31	44	nC
Q _{gs}	Gate to Source Charge I _D = 14 A		14		nC
Q_{gd}	Gate to Drain "Miller" Charge		8.0		nC
Q _{oss}	Output Charge	V _{DD} = 40 V, V _{GS} = 0 V	42		nC

Drain-Source Diode Characteristics

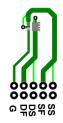
V _{SD} Source to Drain Diode Forward Voltage	Source to Drain Diode, Ferward Voltage	$V_{GS} = 0 \text{ V}, I_S = 14 \text{ A}$ (Note 2)		0.8	1.3	V
	$V_{GS} = 0 \text{ V}, I_{S} = 1.9 \text{ A}$ (Note 2)		0.7	1.2	V	
t _{rr}	Reverse Recovery Time	-I _F = 14 A, di/dt = 100 A/μs		41	66	ns
Q _{rr}	Reverse Recovery Charge			25	40	nC

Notes:

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. E_{AS} of 216 mJ is based on starting $T_{J} = 25$ °C, L = 3 mH, $I_{AS} = 12$ A, $V_{DD} = 80$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 37$ A.
- 4. Pulsed Id limited by junction temperature, td<=100 μ S, please refer to SOA curve for more details.

Typical Characteristics T_J = 25 °C unless otherwise noted

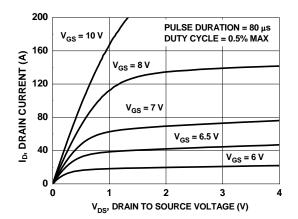


Figure 1. On-Region Characteristics

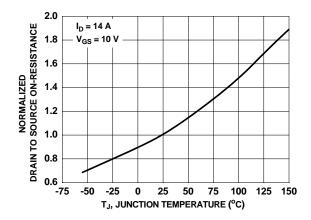


Figure 3. Normalized On-Resistance vs Junction Temperature

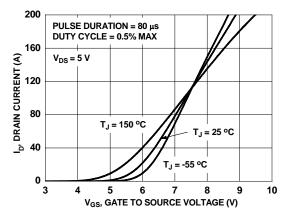


Figure 5. Transfer Characteristics

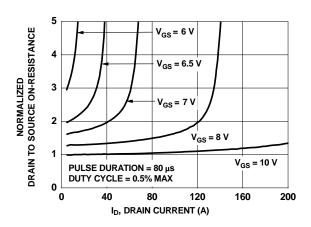


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

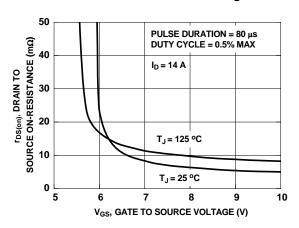


Figure 4. On-Resistance vs Gate to Source Voltage

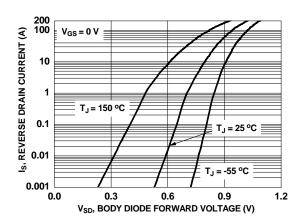


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

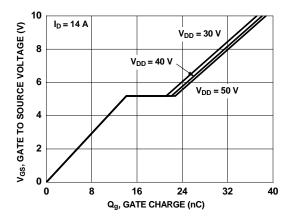


Figure 7. Gate Charge Characteristics

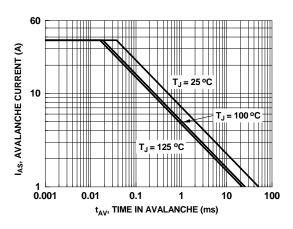


Figure 9. Unclamped Inductive Switching Capability

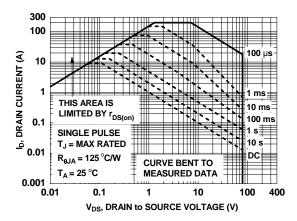


Figure 11. Forward Bias Safe Operating Area

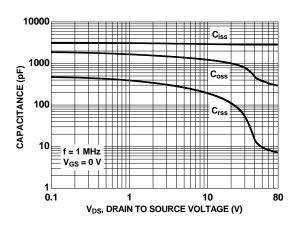


Figure 8. Capacitance vs Drain to Source Voltage

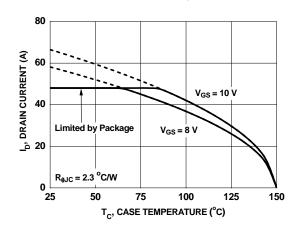


Figure 10. Maximum Continuous Drain Current vs Case Temperature

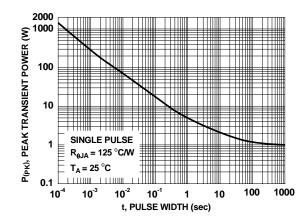


Figure 12. Single Pulse Maximum Power Dissipation



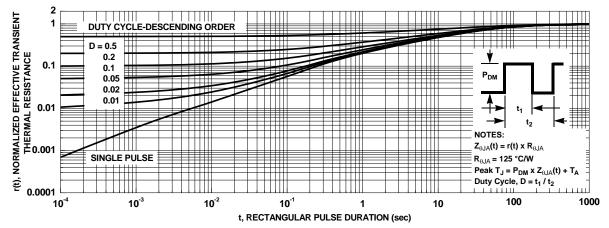
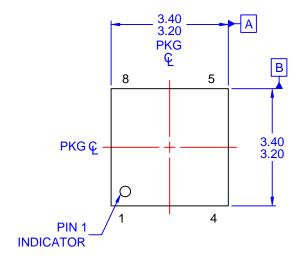
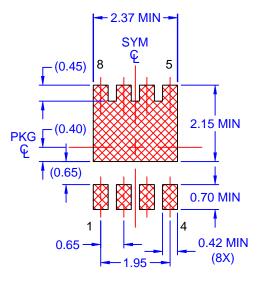
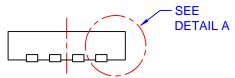


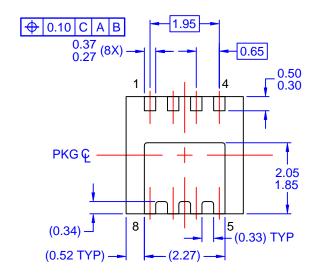
Figure 13. Junction-to-Ambient Transient Thermal Response Curve





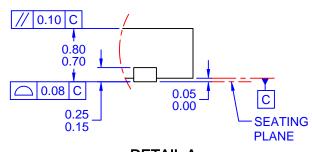


LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) DRAWING FILE NAME: PQFN08HREV1



DETAIL A





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Definition of Terms

Deminition of Terms		
Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
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